

**Search Notes**

Application/Control No.

10/815,370

Examiner

TRONG PHAN

Applicant(s)/Patent under  
Reexamination

YEH ET AL.

Art Unit

2827

**SEARCHED**

Class	Subclass	Date	Examiner
365	185.11	12/21/2005	TP
	185.18		
	185.28		
	185.29		
	185.33		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	12/21/2005	TP